

CoolMOS® Power Transistor

Features

- Worldwide best $R_{
 m ds,on}$ in TO247
- · Ultra low gate charge
- Extreme dv/dt rated
- · High peak current capability
- Qualified for industrial grade applications according to JEDEC¹⁾
- Pb-free lead plating; RoHS compliant

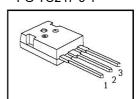
CoolMOS CP is specially designed for:

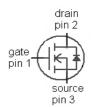
• Hard switching SMPS topologies

Product Summary

V _{DS} @ T _{jmax}	650	٧
R _{DS(on),max}	0.045	Ω
Q _{g,typ}	150	nC







Туре	Package	Ordering Code	Marking
IPW60R045CP	PG-TO247-3-1	SP000067149	6R045

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C	60	А
		T _C =100 °C	38	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	230	
Avalanche energy, single pulse	E _{AS}	/ _D =11 A, V _{DD} =50 V	1950	mJ
Avalanche energy, repetitive $t_{AR}^{(2),3)}$	E _{AR}	/ _D =11 A, V _{DD} =50 V	3	
Avalanche current, repetitive $t_{AR}^{(2),3)}$	I _{AR}		11	А
MOSFET dv/dt ruggedness	dv/dt	V _{DS} =0480 V	50	V/ns
Gate source voltage	V _{GS}	static	±20	V
		AC (f>1 Hz)	±30	
Power dissipation	P _{tot}	T _C =25 °C	431	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
Mounting torque		M3 and M3.5 screws	60	Ncm

Unit

Values



Parameter

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous diode forward current / _S		Т _С =25 °С	44	А
Diode pulse current ²⁾	I _{S,pulse}	7 _C -23 G	230	
Reverse diode dv/dt ⁴⁾	d <i>v l</i> dt		15	V/ns

			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R _{thJC}		-	-	0.29	K/W
Thermal resistance, junction - ambient	$R_{ m thJA}$	leaded	ı	1	62	
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	-	-	260	°C

Symbol Conditions

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =250 μA	600	-	-	V
Gate threshold voltage	V _{GS(th)}	$V_{\rm DS} = V_{\rm GS}$, $I_{\rm D} = 3$ mA	2.5	3	3.5	
Zero gate voltage drain current	I _{DSS}	V _{DS} =600 V, V _{GS} =0 V, T _j =25 °C	1	1	10	μA
		V _{DS} =600 V, V _{GS} =0 V, T _j =150 °C	1	50	-	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	1	100	nA
Drain-source on-state resistance R _{DS(or}		V _{GS} =10 V, I _D =44 A, T _j =25 °C	1	0.04	0.045	Ω
		V _{GS} =10 V, I _D =44 A, T _j =150 °C	-	0.11	-	
Gate resistance	R _G	f=1 MHz, open drain	-	1.3	-	Ω



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss	V _{GS} =0 V, V _{DS} =100 V,	-	6800	-	pF
Output capacitance	C oss	f=1 MHz	ı	320	1	
Effective output capacitance, energy related ⁵⁾	C _{o(er)}	V _{GS} =0 V, V _{DS} =0 V	-	310	-	
Effective output capacitance, time related ⁶⁾	C _{o(tr)}	to 480 V	-	820	-	
Turn-on delay time	t _{d(on)}		-	30	-	ns
Rise time	t _r	V _{DD} =400 V, V _{GS} =10 V, I _D =44 A,	-	20	-	
Turn-off delay time	$t_{d(off)}$	$R_{\rm G}$ =3.3 Ω	-	100	-	
Fall time	t _f		-	10	-	
Gate Charge Characteristics						
Gate to source charge	Q _{gs}		-	34	-	nC
Gate to drain charge	Q_{gd}	V _{DD} =400 V, I _D =44 A,	-	51	-	
Gate charge total	Qg	V _{GS} =0 to 10 V	-	150	190	
Gate plateau voltage	V _{plateau}]	-	5.0	-	V
Reverse Diode						
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =44 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time	t _{rr}		-	600	-	ns
Reverse recovery charge	Qrr	V _R =400 V, I _F =I _S , di _F /dt=100 A/μs	-	17	-	μC
Peak reverse recovery current	/ _{rrm}		-	60	-	А

¹⁾ J-STD20 and JESD22

²⁾ Pulse width t_p limited by $T_{i,max}$

 $^{^{3)}}$ Repetitive avalanche causes additional power losses that can be calculated as $P_{\rm AV}$ = $E_{\rm AR}$ * $f_{\rm AV}$

 $^{^{4)}} I_{\text{SD}} \leq I_{\text{D}}, \text{ d}iI\text{d}t \leq 100\text{A/}\mu\text{s}, \text{V}_{\text{DClink}} = 400\text{V}, \text{ V peak} < V_{\text{(BR)DSS}}, \text{ } T_{\text{j}} < T_{\text{jmax}}, \text{ identical low side and high side switch}$

 $^{^{5)}}$ $C_{\rm o(er)}$ is a fixed capacitance that gives the same stored energy as $C_{\rm oss}$ while $V_{\rm DS}$ is rising from 0 to 80% $V_{\rm DSS}$.

 $^{^{6)}}$ C $_{o(tr)}$ is a fixed capacitance that gives the same charging time as C $_{oss}$ while V_{DS} is rising from 0 to 80% V_{DSS} .



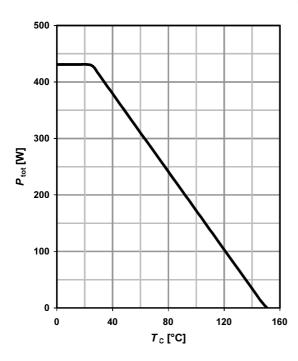
1 Power dissipation

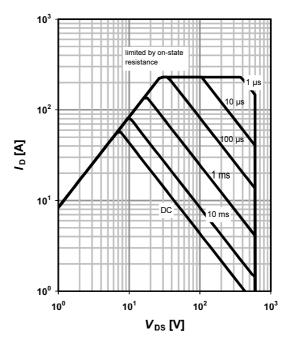
 P_{tot} =f(T_{C})

2 Safe operating area

 $I_D = f(V_{DS}); T_C = 25 °C; D = 0$

parameter: t_p





3 Max. transient thermal impedance

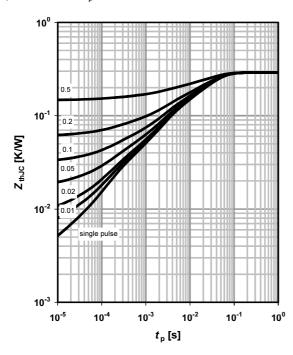
 $Z_{(thJC)}$ = $f(t_p)$

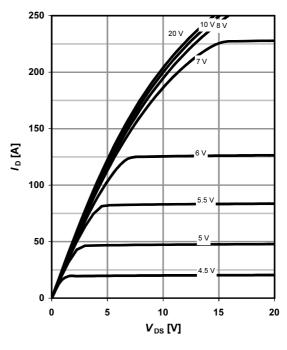
parameter: D=t_p/T

4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C$

parameter: V_{GS}



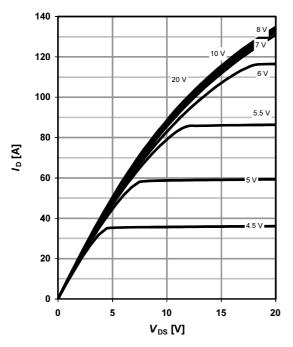




5 Typ. output characteristics

 $I_{D} = f(V_{DS}); T_{j} = 150 \text{ °C}$

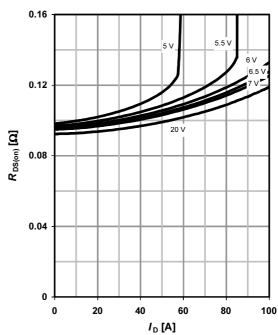
parameter: V_{GS}



6 Typ. drain-source on-state resistance

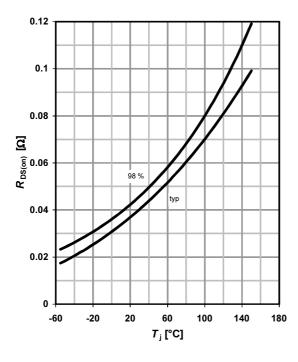
 $R_{DS(on)}=f(I_D); T_j=150 °C$

parameter: V_{GS}



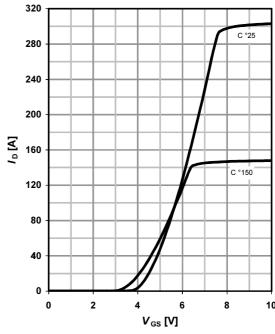
7 Drain-source on-state resistance

 $R_{DS(on)}$ =f(T_i); I_D =44 A; V_{GS} =10 V



8 Typ. transfer characteristics

 $I_{\rm D}$ =f($V_{\rm GS}$); $|V_{\rm DS}|$ >2 $|I_{\rm D}|R_{\rm DS(on)max}$ parameter: $T_{\rm j}$

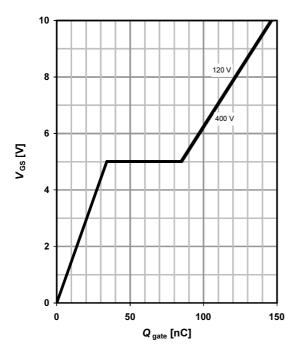




9 Typ. gate charge

V_{GS} =f(Q_{gate}); I_D =44 A pulsed

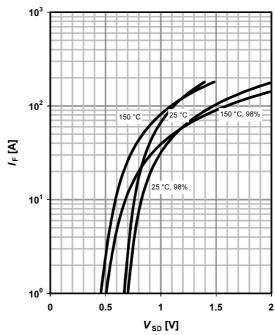
parameter: $V_{\rm DD}$



10 Forward characteristics of reverse diode

 $I_F = f(V_{SD})$

parameter: T_j

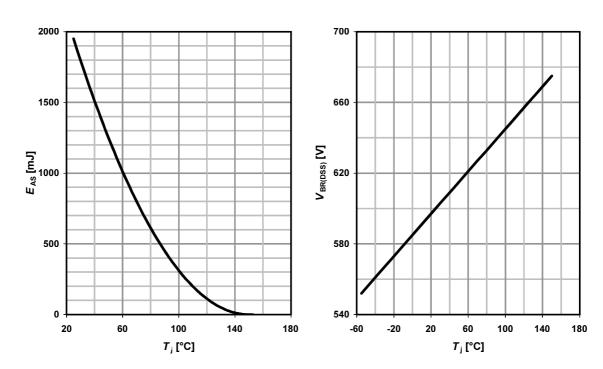


11 Avalanche energy

$$E_{AS}$$
=f(T_i); I_D =11 A; V_{DD} =50 V

12 Drain-source breakdown voltage

 $V_{BR(DSS)}$ = $f(T_j)$; I_D =0.25 mA



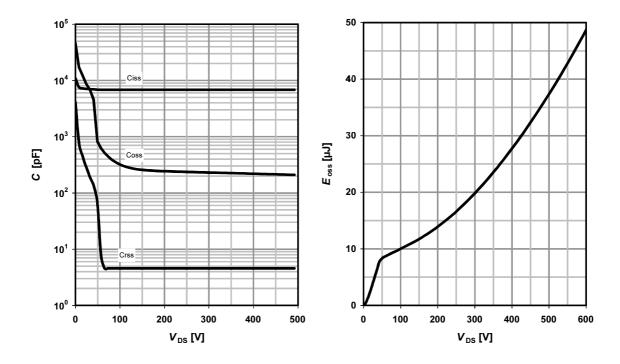


13 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$

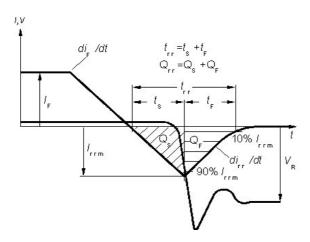
14 Typ. Coss stored energy

$$E_{oss} = f(V_{DS})$$

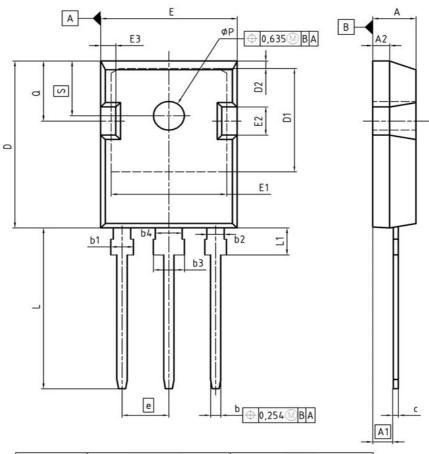




Definition of diode switching characteristics



PG-TO-247-3: Outlines



DIM	MILLIM	ETERS	INCH	HES
DIM	MIN	MAX	MIN	MAX
Α	4.90	5.16	0.193	0.203
A1	2.27	2.53	0.089	0.099
A2	1.85	2.11	0.073	0.083
Ь	1.07	1.33	0.042	0.052
ь1	1.90	2.41	0.075	0.095
b2	1.90	2.16	0.075	0.085
b3	2.87	3.38	0.113	0.133
b4	2.87	3.13	0.113	0.123
С	0.55	0.68	0.022	0.027
D	20.82	21.10	0.820	0.831
D1	16.25	17.65	0.640	0.695
D2	1.05	1.35	0.041	0.053
E	15.70	16.03	0.618	0.631
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.68	2.60	0.066	0.102
е	5.	44	0.2	214
N	1 1	3		3
L	19.80	20.31	0.780	0.799
L1	4.17	4.47	0.164	0.176
øΡ	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248

DOCUMEN Z8B00003	
SCALE	0
0 5	5 – 7.5mm
EUROPEAN P	ROJECTION
	\bigoplus
ISSUE [17-12-2	
REVISIO 03	ON



Published by
Infineon Technologies AG
81726 Munich, Germany
© 2007 Infineon Technologies AG
All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office. The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



New package outlines TO-247

1 New package outlines TO-247

Assembly capacity extension for CoolMOSTM technology products assembled in lead-free package PG-TO247-3 at subcontractor ASE (Weihai) Inc., China (Changes are marked in blue.)

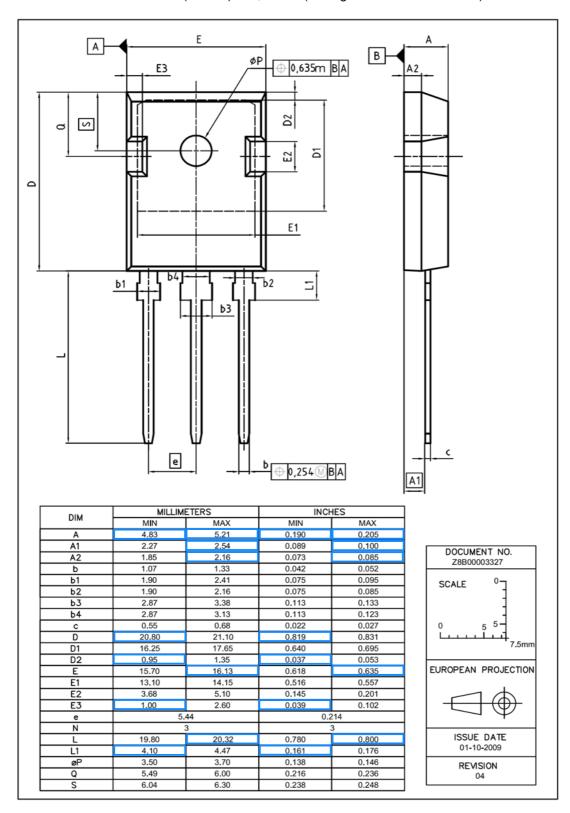


Figure 1 Outlines TO-247, dimensions in mm/inches

Final Data Sheet Erratum Rev. 2.0, 2010-02-01